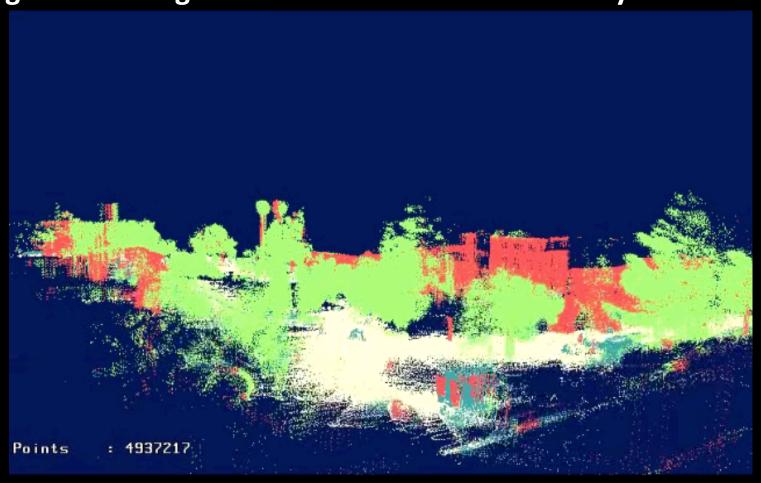
Discriminative Learning of Markov Random Fields for Segmentation of 3D Scan Data

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3D Segmentation

e.g. 3D scan segmentation of Stanford University



3D Segmentation

- Why is this challenging?
 - 3D scanning points lack color clues
 - data is often noisy and sparse
 - extracting features for unseen object can be hard
- 1. How to compactly represent model?
- 2. How to efficiently inference with the model?

Paper Highlight

1. Higher prediction accuracy than SVM

- Markov Random Fields (MRFs) incorporate both node and edge features
- Enforce the preference that adjacent points have the same label.

2. Higher computational efficiency than CRFs

- Formulate a compact quadratic programming based on maximum-margin framework, making the estimation tractable.
- Scale up to tens of millions of points and multiple object classes.

Learning Algorithm Overview

Learning Phase

- Training data: scene points labeled with classes
- Goal: find a good set of feature weights $w = (w_n, w_e)$
- Approach: maximum margin Markov network (M³N)

Segmentation Phase

- Goal: classify the points of a new scene
- Approach: compute both point and edge features and run the graph-cut algorithm using the weights \overrightarrow{w} .

- Motivation: neighboring scan points can be correlated
- Definitions:
 - Markov network G = (V, E), $V = \{1, 2, ..., N\}$
 - Edge (i,j): probabilistic interaction between nodes
 - Labels are the discrete variables $\mathbf{Y} = \{Y_1, Y_2, ..., Y_N\}$, where $Y_i \in \{1, 2, ..., K\}$

- Nodes and edges associated with potentials $\; \phi_i(Y_i)$, $\; \phi_{ij}(Y_i,Y_j)$
- Associative Markov Network: $\phi_{ij}(k,k) \ge 1$, $\phi_{ij}(k,l) = 1 \ \forall k \ne l$
- The joint distribution specified by the network is:

$$P_{\phi}(\mathbf{y}) = \frac{1}{Z} \prod_{i=1}^{N} \phi_i(y_i) \prod_{ij \in E} \phi_i(y_i, y_j)$$

where Z is the partition function given by

$$Z = \sum_{v'} \prod_{i=1}^{N} \phi_i(y_i^{'}) \prod_{ij \in E} \phi_i(y_i^{'}, y_j^{'})$$

Dependence of potentials on features: $\log \phi_i(k) = \mathbf{w}_n^k \cdot \mathbf{x}_i$ and

$$\log \phi_{ii}(k,k) = \mathbf{w}_e^k \cdot \mathbf{x}_{ii}$$

- Maximum a posteriori (MAP) inference:
 - find the maximum of the conditional distribution:

$$\log P_{\mathbf{w}}(\mathbf{y} \mid \mathbf{x}) = \sum_{i=1}^{N} \sum_{k=1}^{K} (\mathbf{w}_{n}^{k} \cdot \mathbf{x}_{i}) y_{i}^{k} + \sum_{ij \in E} \sum_{k=1}^{K} (\mathbf{w}_{e}^{k} \cdot \mathbf{x}_{ij}) y_{i}^{k} y_{j}^{k}$$
where $y_{i}^{k} = I(y_{i} = k)$

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- formulate the problem as integer programming:

$$\max \sum_{i=1}^{N} \sum_{k=1}^{K} (\mathbf{w}_{n}^{k} \cdot \mathbf{x}_{i}) y_{i}^{k} + \sum_{ij \in E} (\mathbf{w}_{e}^{k} \cdot \mathbf{x}_{ij}) y_{ij}^{k}$$

$$s.t. \quad y_{i}^{k}, y_{j}^{k} \in \{0,1\}$$

$$y_{ij}^{k} \leq y_{i}^{k}, \quad y_{ij}^{k} \leq y_{j}^{k}, \quad \forall ij \in E, k.$$

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Why these two problems are equaivalent?

- Maximum a posteriori (MAP) inference:
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where $y_{i}^{k} = I(y_{i} = k)$

- Using linear programming relaxation:

$$\max \sum_{i=1}^{N} \sum_{k=1}^{K} (\mathbf{w}_{n}^{k} \cdot \mathbf{x}_{i}) y_{i}^{k} + \sum_{ij \in E} (\mathbf{w}_{e}^{k} \cdot \mathbf{x}_{ij}) y_{ij}^{k}$$

$$s.t. \quad y_{i}^{k} \geq 0, \ \forall i, k; \ \sum_{k} y_{i}^{k} = 1, \ \forall i;$$

$$y_{ij}^{k} \leq y_{i}^{k}, \ y_{ij}^{k} \leq y_{j}^{k}, \ \forall ij \in E, k.$$

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$$\log P_{\mathbf{w}}(\mathbf{y}|\mathbf{x}) = \sum_{i=1}^{N=2} \sum_{k=1}^{K=2} (\mathbf{w}_{n}^{k} \cdot \mathbf{x}_{i}) y_{i}^{k} + \sum_{i,j \in \mathcal{E}} \sum_{k=1}^{K=2} (\mathbf{w}_{e}^{k} \cdot \mathbf{x}_{ij}) y_{ij}^{k}$$

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$$= (\mathbf{w}_{n}^{1} \cdot \mathbf{x}_{1}) y_{1}^{1} + (\mathbf{w}_{n}^{2} \cdot \mathbf{x}_{1}) y_{1}^{2} + (\mathbf{w}_{n}^{1} \cdot \mathbf{x}_{2}) y_{2}^{1} + (\mathbf{w}_{n}^{2} \cdot \mathbf{x}_{2}) y_{2}^{2}$$

$$+ (\mathbf{w}_{e}^{1} \cdot \mathbf{x}_{12}) y_{12}^{1} + (\mathbf{w}_{e}^{2} \cdot \mathbf{x}_{12}) y_{12}^{2}$$

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$$= \left(egin{array}{cccc} \mathbf{w}_n^1 & \mathbf{w}_n^2 & \mathbf{w}_e^1 & \mathbf{w}_e^2 \end{array}
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$$= \begin{pmatrix} \mathbf{w}_{n}^{1} & \mathbf{w}_{n}^{2} & \mathbf{w}_{e}^{1} & \mathbf{w}_{e}^{2} \end{pmatrix} \begin{pmatrix} \mathbf{x}_{1} & 0 & \mathbf{x}_{2} & 0 & 0 & 0 \\ 0 & \mathbf{x}_{1} & 0 & \mathbf{x}_{2} & 0 & 0 & 0 \\ 0 & 0 & 0 & 0 & \mathbf{x}_{12} & 0 & 0 \\ 0 & 0 & 0 & 0 & 0 & \mathbf{x}_{12} & 0 \end{pmatrix}$$

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 $= \mathbf{w} \cdot \mathbf{X} \cdot \mathbf{y}$

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Maximum margin estimation:

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- Want the gain to scale linearly with the number of mislabeled points $l\left(\hat{\mathbf{y}},\mathbf{y}\right)$:

$$\max \gamma \text{ s.t. } \mathbf{w} \mathbf{X} (\hat{\mathbf{y}} - \mathbf{y}) \ge \gamma l (\hat{\mathbf{y}}, \mathbf{y})$$
$$||\mathbf{w}||^2 \le 1$$

•Note that
$$l\left(\hat{\mathbf{y}},\mathbf{y}\right)=N-\hat{\mathbf{y}}_{n}^{\top}\mathbf{y}_{n}$$

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ullet Add in a slack variable $m{\mathcal{E}}$

$$\min \quad \frac{1}{2}\mathbf{w}^2 + C\xi$$

s.t.
$$\mathbf{w}\mathbf{X}(\hat{\mathbf{y}} - \mathbf{y}) \ge N - \hat{\mathbf{y}}_n^{\mathsf{T}}\mathbf{y}_n - \xi, \, \forall \mathbf{y} \in \mathcal{Y}$$

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 Exponentially many constraints → replace them with a single nonlinear constraint,

$$\mathbf{w}\mathbf{X}\hat{\mathbf{y}} - N + \xi \ge \max_{\mathbf{y} \in \mathcal{Y}} \mathbf{w}\mathbf{X}\mathbf{y} - \hat{\mathbf{y}}_n^{\mathsf{T}}\mathbf{y}_n$$

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Where the right hand side can be found using the MAP

•Plugging the dual of the MAP linear program, we get the following quadratic program for learning the weights:

min
$$\frac{1}{2} |\mathbf{w}|^2 + C\xi$$
s.t.
$$\mathbf{w} \mathbf{X} \hat{\mathbf{y}} - N + \xi \ge \sum_{i=1}^{N} \alpha_i; \ \mathbf{w}_e \ge 0;$$

$$\alpha_i - \sum_{i,j \in \mathcal{E}} \alpha_{ij}^k \ge \mathbf{w}_n^k \cdot \mathbf{x}_i - y_i^k, \ \forall i, k;$$

$$\alpha_{ij}^k + \alpha_{ji}^k \ge \mathbf{w}_e^k \cdot \mathbf{x}_{ij}, \ \alpha_{ij}^k, \alpha_{ji}^k \ge 0, \ \forall i, j \in \mathcal{E}, k$$

Experiment: Terrain classification

- Data set: 3-D map of parts of Stanford from a robot equipped with a laser scanner
 - 35 million noisy 3-D points
- •Classify points into:
 - Ground, Building, Tree, Shrubbery
- Classifying the ground is trivial
 - Threshold the z-coordinate at ~0

Features

- 1. Distribution of surrounding points relative to principal plane
- 2. Distribution of points in vertical cylinder (r=0.25m)
- 3. Binary feature: whether within 2m of the ground

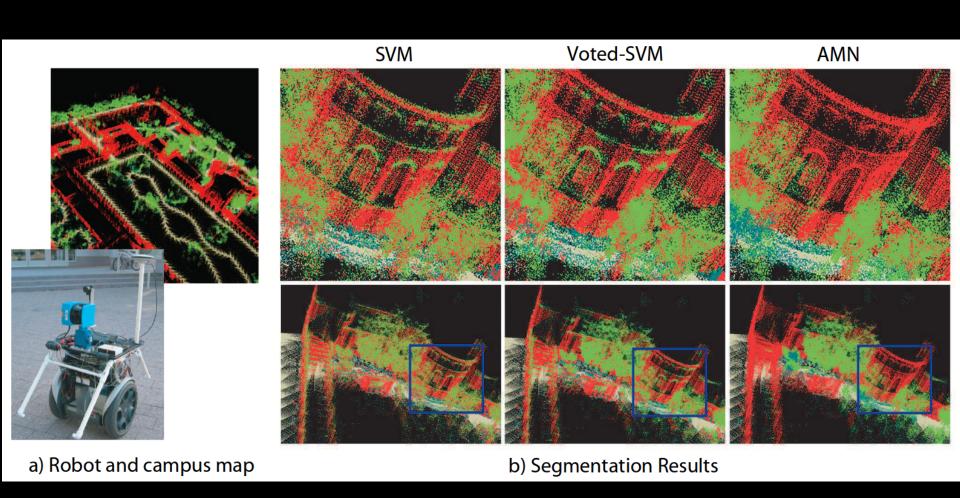
Edges

- Associative Markov Network (AMN) requires pair-wise connections ('edges')
- Each point is randomly connected to 6 other points
 - 3 from sphere of radius 0.5m
 - 3 from vertical cylinder of radius 0.25m

Experimental Setup

- •Training:
 - Roughly 30,000 images that represent the classes well
- Compare multi-class SVM, Voted SVM, and AMN
 - All used same training data and features

Results



Accuracy: SVM: 68%, Voted-SVM: 73%, AMN: 93%

Conclusions

- •A simple Associative Markov Network (AMN) model was introduced for segmenting 3D image data
 - Model rewards cases where nearby points have the same label
- Classification is done by maximum a-posteriori (MAP) inference,
 which maximizes the log-likelihood
- •Training of the weights is done by maximizing the margin between the log-likelihoods of the true labeling \hat{y} and any other labeling y
- •Experiments on classifying 3D images demonstrated a large gain in accuracy over an SVM